Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/826,259	ONO ET AL.	
Examiner	Art Unit	
Long Pham	2814	

SEARCHED				
Class	Subclass	Date	Examiner	
438	270,242 329,330	1/22/2006	LP	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
438	270	1/22/2006	LP	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
text searches updated	1/22/2006	LP